Search Notes				

Application/Control N	o. Applicant(s)/Patent und Reexamination	er
10/671,473	YAGISHITA ET AL.	
Examiner	Art Unit	
Ly D. Pham	2827	

SEARCHED			
Class	Subclass	Date	Examiner
365	200, 63, 191, 214	8/22/2005	LP
365	230.03	8/22/2005	LP
365	230.06	8/22/2005	LP
365	230.08	8/22/2005	LP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	data base	8/22/2005	LP
search (	attached)		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East (update search)	8/22/2005	LP
Interference search queries (see attached)	8/22/2005	LP